

EAST Search History

Ref #	Hits	Search Query	DBs	Default Operator	Plurals	Time Stamp
L1	106902	(widen\$3 or increas\$3 or expand\$3 or enlarg\$3) near2 (spac\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:19
L2	160163	(provid\$3 or widen\$3 or increas\$3 or expand\$3 or enlarg\$3) near2 (spac\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:21
L3	126	L2 with (adjacent adj (structure or element or device or cell))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:22
L4	128	L2 with (adjacent adj (structure or element or device or cell or shape))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:23
L5	101	L4 and (layout or pattern or wafer or chip or circuit or manufactur\$7)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:25
L6	14	L5 and layout	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:33
L7	12262	((widen\$3 or wider or wid\$5) near3 edge) with (structure or element or cell or device or shape or object)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:35
L8	705	L7 and layout	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:35
L9	478	L8 and circuit	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:35

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L10	379	L9 and pattern\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:42
L11	0	L10 and ((poor or worse or bad or lower or poorer) near2 (manufacturability))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:37
L12	147	L10 and wafer	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:42
L13	33	L12 and simulat\$4	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:56
L14	79459	sem or SEM or (scan\$4 adj electron adj microscope)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:59
L15	3921	L14 with wafer	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:59
L16	7756	L14 with (wafer or substrate)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:00
L17	9628	L14 near3 image	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:59
L18	1317	L17 with (wafer or substrate)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:02
L19	16	L18 same (problematic or poor\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:12

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L20	0	L19 same manufacturability	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:02
L21	0	L19 same manufactur\$6	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:03
L22	0	L19 same manufactur\$8	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:03
L23	115	(problematic or poor\$3) near3 manufacturability	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:13
L24	115	(problematic or poor\$3 or weak\$5) near3 manufacturability	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:23
L25	8	L24 and (adjacent near3 (structure or element or device or object or cell))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:44
L26	9	L24 and ((adjacent or close) near3 (structure or element or device or object or cell))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:45
L27	54	L24 and spac\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 11:45
S1	401879	(increas\$3 or more or add\$3 or additional or wid\$3) near3 (spac\$3)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/08 10:17
S2	213	S1 near5 (adjacent adj (structure or component or element or cell or image))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 15:39

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S3	35	S2 and layout	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 15:39
S4	27	S3 and pattern\$3	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:01
S5	1395	provid\$3 near3 ((additional or more or extra or excess\$4) adj (space))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:03
S6	1613	provid\$3 near3 ((additional or more or extra or excess\$4) adj (spac\$4))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:03
S7	0	S6 with (adjacent adj (structure or element or component or cell or image))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:04
S8	4	S6 same (adjacent adj (structure or element or component or cell or image))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:05
S9	315087	(more or additional or add\$3 or increas\$3 or extra or excess\$4) near3 (spac\$4)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:07
S10	100	S9 near5 (adjacent adj (structure or cell or component or element or image))	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:08
S11	53	S10 and (layout or pattern)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:10
S12	7	S10 and (layout and pattern)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:09

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S13	700	(great\$3 or better or worse or less\$3 or poor\$3) near3 (manufacturability)	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:09
S14	0	S10 and S13	US-PGPUB; USPAT; EPO; JPO; DERWENT; IBM_TDB	OR	ON	2007/08/07 16:09